

BSC105N10LSF G-VB Datasheet N-Channel 100-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | |
|--------------------------|---------------------------------|--------------------|--|--|--|
| V _{(BR)DSS} (V) | $r_{DS(on)}(\Omega)$ | I _D (A) | | | |
| 100 | 0.009 at V _{GS} = 10 V | 65 | | | |

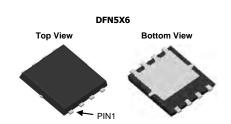
FEATURES

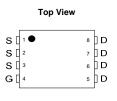
- TrenchFET® Power MOSFET
- 175 °C Junction Temperature
- Low Thermal Resistance Package
- 100 % R_g Tested

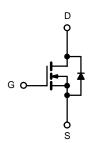


APPLICATIONS

• Isolated DC/DC Converters







N-Channel MOSFET

| ABSOLUTE MAXIMUM RATING | S (T _A = 25 °C, u | nless other | wise noted) | | |
|---|-------------------------------------|-----------------------------------|----------------------|------|--|
| PARAMETER | | SYMBOL | LIMIT | UNIT | |
| Drain-source voltage | | V_{DS} | 100 | V | |
| Gate-source voltage | | V_{GS} | ± 20 | V | |
| | T _C = 25 °C | | 65 | | |
| O-ations and design and (T 150 °C) | T _C = 70 °C | † . ! | 60 | | |
| Continuous drain current (T _J = 150 °C) | T _A = 25 °C | l _D | 20 b, c | | |
| | T _A = 70 °C | 1 | 18.5 ^{b, c} | | |
| Pulsed drain current (t = 100 µs) | | I _{DM} | 180 | A | |
| Continuous source-drain diode current | T _C = 25 °C | | 60 | | |
| | T _A = 25 °C | l _S | 4.8 b, c | | |
| Single pulse avalanche current | | I _{AS} | 30 | 7 | |
| Single pulse avalanche energy | L = 0.1 mH | E _{AS} | 40 | mJ | |
| | T _C = 25 °C | | 80 | | |
| Maximum naugudiacination | T _C = 70 °C | Б | 50 | w | |
| Maximum power dissipation | T _A = 25 °C | P _D | 5 b, c | VV | |
| | T _A = 70 °C | | 3.2 ^{b, c} | | |
| Operating junction and storage temperature range | | T _J , T _{stg} | -55 to +150 | °C | |
| Soldering recommendations (peak temperature) ^c | | | 260 | | |

| THERMAL RESISTANCE RATINGS | | | | | | | |
|----------------------------------|--------------|-------------------|---------|---------|------|--|--|
| PARAMETER | | SYMBOL | TYPICAL | MAXIMUM | UNIT | | |
| Maximum junction-to-ambient b | t ≤ 10 s | R _{thJA} | 20 | 25 | °C/W | | |
| Maximum junction-to-case (drain) | Steady state | $R_{th,IC}$ | 1.6 | 2 | C/VV | | |

Notes

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s

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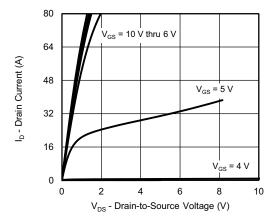
| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|-------------------------|--|------|--------|------|-----------|
| Static | <u> </u> | | | | | |
| Drain-source breakdown voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 100 | - | - | V |
| V _{DS} temperature coefficient | $\Delta V_{DS}/T_{J}$ | I _D = 10 mA | - | 81 | - | ma\ 1/0.0 |
| V _{GS(th)} temperature coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = 250 μA | - | -7.5 | - | mV/°C |
| Gate-source threshold voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 3 | - | 5 | V |
| Gate-source leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | - | - | 100 | nA |
| Zoro goto voltogo droin current | I _{DSS} | V _{DS} = 100 V, V _{GS} = 0 V | - | - | 1 | μΑ |
| Zero gate voltage drain current | | V _{DS} = 100 V, V _{GS} = 0 V, T _J = 70 °C | - | - | 15 | |
| On-state drain current ^a | I _{D(on)} | $V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$ | 40 | - | - | Α |
| 5 | _ | V _{GS} =10 V, I _D = 10 A | - | 0.009 | - | Ω |
| Drain-source on-state resistance ^a | R _{DS(on)} | $V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$ | - | 0.012 | - | |
| Forward transconductance ^a | 9 _{fs} | $V_{DS} = 15 \text{ V}, I_D = 10 \text{ A}$ | - | 46 | - | S |
| Dynamic ^b | | | • | • | • | |
| Input capacitance | C _{iss} | | - | 3970 | - | pF |
| Output capacitance | C _{oss} | $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | - | 132 | - | |
| Reverse transfer capacitance | C _{rss} | | - | 11.2 | - | |
| Total gate charge | Qg | $V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ | - | - 20 - | | |
| | | | - | 15 | - | nC |
| Gate-source charge | Q_{gs} | $V_{DS} = 50 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$ | - | 6.45 | - | |
| Gate-drain charge | Q_{gd} | | - | 3.5 | - | |
| Output charge | Q _{oss} | $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$ | - | 22 | - | |
| Gate resistance | R_{g} | f = 1 MHz | 0.2 | 0.76 | 1.4 | Ω |
| Turn-on delay time | t _{d(on)} | | - | 12 | 24 | |
| Rise time | t _r | $V_{DD} = 50 \text{ V}, \text{ R}_L = 5 \Omega, \text{ I}_D \cong 10 \text{ A},$ | - | 5 | 10 | 1 |
| Turn-off delay time | t _{d(off)} | $V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$ | - | 19 | 38 | |
| Fall time | t _f | | - | 5 | 10 |] |
| Turn-on delay time | t _{d(on)} | | - | 15 | 30 | ns |
| Rise time | t _r | V_{DD} = 50 V, R_L = 5 Ω , $I_D \cong$ 10 A, | - | 6 | 12 | |
| Turn-off delay time | t _{d(off)} | $V_{GEN} = 7.5 \text{ V}, R_g = 1 \Omega$ | - | 19 | 38 | |
| Fall time | t _f | | - | 5 | 10 | 1 |
| Drain-Source Body Diode Characteristi | cs | | | | | |
| Continuous source-drain diode current | Is | T _C = 25 °C | - | - | 60 | |
| Pulse diode forward current | I _{SM} | | - | - | 80 | A |
| Body diode voltage | V _{SD} | I _S = 5 A, V _{GS} = 0 V | - | 0.78 | 1.1 | V |
| Body diode reverse recovery time | t _{rr} | | - | 43 | 86 | ns |
| Body diode reverse recovery charge | Q _{rr} | | - | 72 | 144 | nC |
| Reverse recovery fall time | t _a | $I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ | - | 33 | - | |
| Reverse recovery rise time | t _b | | - | 10 | - | ns |

Notes

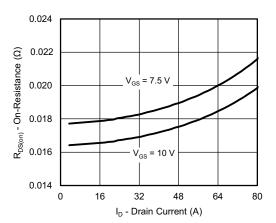
- a. Pulse test; pulse width $\leq 300~\mu s,\,duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

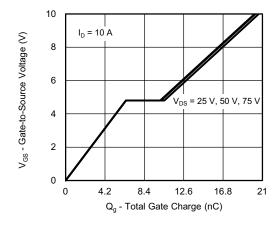




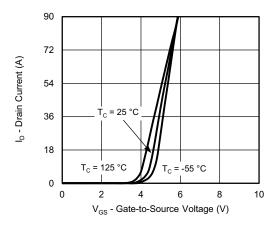
Output Characteristics



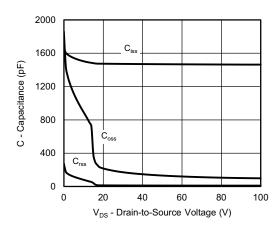
On-Resistance vs. Drain Current and Gate Voltage



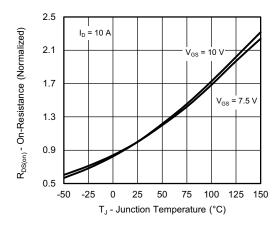
Gate Charge



Transfer Characteristics

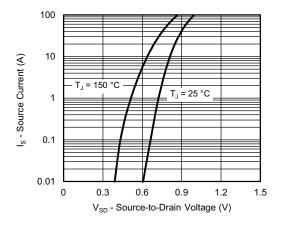


Capacitance

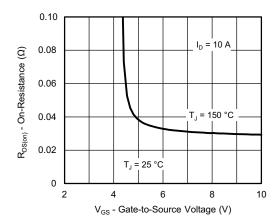


On-Resistance vs. Junction Temperature

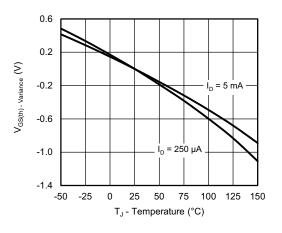




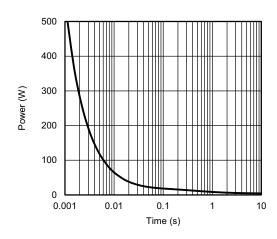
Source-Drain Diode Forward Voltage



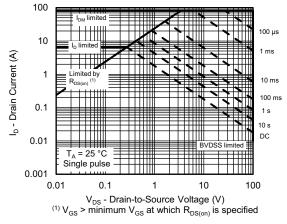
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

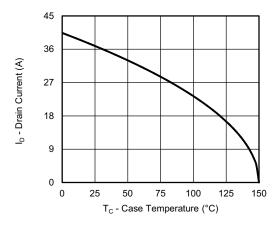


Single Pulse Power, Junction-to-Ambient

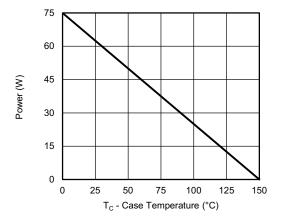


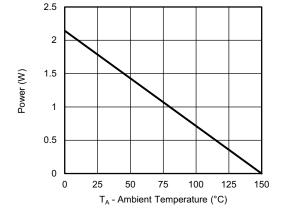
Safe Operating Area, Junction-to-Ambient





Current Derating ^a





Power, Junction-to-Case

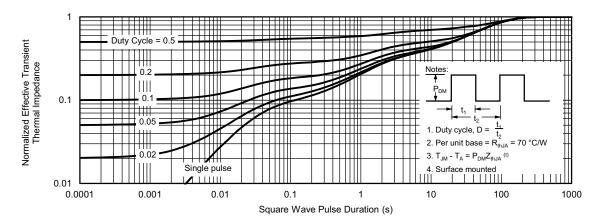
Power, Junction-to-Ambient

Note

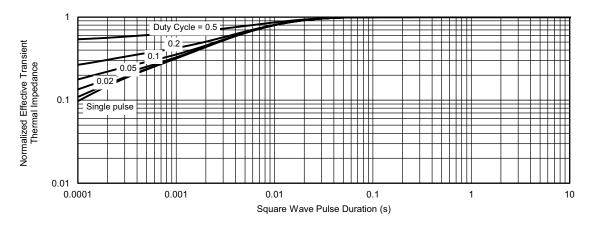
a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

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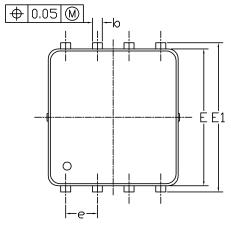
Normalized Thermal Transient Impedance, Junction-to-Ambient

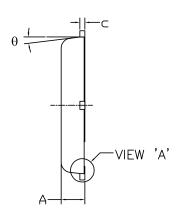


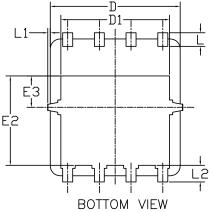
Normalized Thermal Transient Impedance, Junction-to-Case

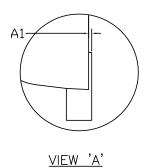


DFN5x6_8L_EP1_P PACKAGE OUTLIN



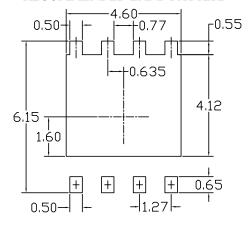






(SCALE 5:1)

RECOMMENDED LAND PATTERN



| SYMBOLS | DIMENSIONS IN MILLIMETERS | | | DIMENSIONS IN INCHES | | |
|-----------|---------------------------|--------|-----------|----------------------|--------|--------|
| 3 I MBOLS | MIN | NOM | MAX | MIN | NOM | MAX |
| A | 0.85 | 0. 95 | 1.00 | 0.033 | 0.037 | 0.039 |
| Al | 0.00 | | 0.05 | 0.000 | | 0.002 |
| b | 0.30 | 0.40 | 0.50 | 0.012 | 0.016 | 0.020 |
| c | 0. 15 | 0. 20 | 0. 25 | 0.006 | 0.008 | 0.010 |
| D | 5. 10 | 5. 20 | 5. 30 | 0. 201 | 0. 205 | 0. 209 |
| D1 | 4. 25 | 4. 35 | 4. 45 | 0. 167 | 0.171 | 0. 175 |
| Е | 5. 45 | 5. 55 | 5. 65 | 0. 215 | 0. 219 | 0. 222 |
| E1 | 5. 95 | 6.05 | 6. 15 | 0. 234 | 0. 238 | 0. 242 |
| E2 | 3. 525 | 3.625 | 3. 725 | 0. 139 | 0. 143 | 0. 147 |
| E3 | 1. 175 | 1. 275 | 1. 375 | 0.046 | 0.050 | 0.054 |
| e | 1. 27 BSC | | | 0.050 BSC | | |
| L | 0.45 | 0. 55 | 0.65 | 0.018 | 0.022 | 0.026 |
| L1 | 0 | | 0. 15 | 0 | | 0.006 |
| L2 | 0.68 REF | | 0.027 REF | | | |
| θ | 0° | | 10° | 0° | | 10° |

NOTE

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
 MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

UNIT: mm



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